

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS : H. MIZUNO, et al.
SERIAL NO. : (Con. of 10/024,039)
FILED : (Herewith)
FOR : SEMICONDUCTOR INTEGRATED CIRCUIT
APPARATUS
GROUP ART UNIT : 2814
EXAMINER : Quan Tra (Anticipated)

COMMISSIONER FOR PATENTS
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Alexandria, Virginia 22313-1450

**INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. § 1.97 & § 1.98**

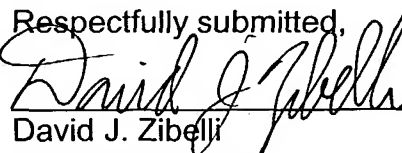
S I R:

In conformance with Applicants' duty of disclosure under 37 C.F.R. § 1.56 and § 1.97(b)(1), the references listed on the attached form PTO-1449 are hereby brought to the Examiner's attention.

Since all of the references have already been considered in parent application Serial No. 10/024,039, no copies of the references are required.

It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear in the "references cited" on any patent to issue therefrom.

Date: 16 July 2003

Respectfully submitted,

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FORM PTO-1449
INFORMATION DISCLOSURE
STATEMENT BY APPLICANT(S)

Atty Docket No. : 29284/599
 Serial No. :
 Inventors : H. Mizuno et al.
 Filed :
 Group Art Unit : 2814
 Examiner : Quan Tra (Anticipated)

U.S. PATENT DOCUMENTS

<u>Examiner Initial</u>	<u>Patent Number</u>	<u>Patent Date</u>	<u>Name</u>	<u>Class/ Subclass</u>	<u>Filing Date</u>
	5,461,338	10-1995	HIRAYAMA et al.	327/314	
	5,557,231	09/07/96	YAMAGUCHI et al.	327/534	
	5,610,533	03/11/97	ARIMOTO et al.	326/33	
	5,703,522	12-1997	ARIMOTO et al.	327/534	
	5,726,562	03-1998	MIZUNO, M.	323/312	
	5,818,212	10-1998	MIN et al.	323/314	
	5,909,140	06-1999	CHOI	327/534	
	6,097,113	08-2000	TERAOKA et al.	307/534	
	6,337,593	01-2002	MIZUNO et al.	327/534	

FOREIGN PATENT DOCUMENTS

<u>Examiner Initial</u>	<u>Document Number</u>	<u>Date</u>	<u>Country</u>	<u>Class/ Subclass</u>	<u>Translation Yes</u>	<u>No</u>
	0 773 448	05/14/97	EPO		N/A	
	7254685	10/03/95	Japan		ABS.	
	10-229165	08/25/98	Japan		ABS.	

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner
Initial

1. IEEE Journal of Solid-State Circuits, Vol. 31, No. 11, Nov. 1996, pp. 1770-1779

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.